

9000 EMC specifications - immunity :

Port	Phenomenon	Test standard	IEC 61326		NAMUR NE21 : 2007		IEC 61326-3-1		PR standard specifications	
			Test value	Criterion	Test value	Criterion	Test value for safety functions	Criterion	Test value	Criterion
Enclosure	ESD input terminals	IEC 61000-4-2	4 kV Contact	B	6 kV Contact	B	6 kV Contact	FS	6 kV Contact	B
	ESD	IEC 61000-4-2	4 kV/8 kV Contact/Air	B	6 kV / 8 kV Contact / Air	A	6 kV / 8 kV Contact / Air	FS	6 kV / 8 kV Contact / Air	A 1%
	HF field	IEC 61000-4-3	10 V/m, 80...1000 MHz 3 V/m, 1.4...2 GHz 1 V/m, 2...2.7 GHz	A	10 V/m, 80...1000 MHz 3...10 V/m, 1.4...2 GHz	A	20 V/m, 80...1000 MHz 10 V/m, 1.4...2 GHz 3 V/m, 2...2.7 GHz	FS	20 V/m, 80...1000 MHz 10 V/m, 1.4...2 GHz 3 V/m, 2...2.7 GHz	A 0.5%
DC power	Magnetic field	IEC 61000-4-8	30 A/m	A	100 A/m	A	30 A/m	FS	30 A/m	A 0.5%
	Burst	IEC 61000-4-4	2 kV	B	2 kV	A	4 kV	FS	4 kV	A 1.0%
	Surge	IEC 61000-4-5	1 kV / 2 kV, Diff. / Comm. 0 Ω/10 Ω	B	0.5 kV / 1 kV, Diff. / Comm. 0 Ω/10 Ω	A	1 kV / 2 kV, Diff. / Comm. 0 Ω/10 Ω	FS	1 kV / 2 kV, Diff. / Comm. 0 Ω / 10 Ω	A 1.0%
	Conducted RF	IEC 61000-4-6	3 V, 150 kHz...80 MHz	A	10 V, 10 kHz...80 MHz Covers RF + LF	A	10 V, 150 kHz...80 MHz	FS	10 V, 150 kHz...80 MHz	A 0.5%
	Interruptions	IEC 61000-4-29	60% for 10 ms 100% for 20 ms	B	100% for 20 ms	A	60% for 10 ms 100% for 20 ms	FS	60% for 10 ms 100% for 20 ms	B
I/O signal	Conducted LF	IEC 61000-4-16	Not required		Not required		1.5...15 kHz, 1...10 V 15...150 kHz, 10 V 50/60 Hz, 100 V	FS	15 Hz...150 kHz, 10 V 50 Hz, 300 Ω, 230 V	A 0.5%
	Burst	IEC 61000-4-4	2 kV	B	2 kV	A	2 kV	FS	2 kV	A 1.0%
I/O signal	Surge input	IEC 61000-4-5	1 kV / 2 kV, Diff. / Comm. 40 Ω	B	0.5 kV / 1 kV, Diff. / Comm. 40 Ω	B	2 kV Comm. 40 Ω	FS	1 kV / 2 kV Diff. / Comm. 40 Ω	B
	Surge output	IEC 61000-4-5	1 kV / 2 kV, Diff. / Comm. 40 Ω	B	0.5 kV / 1 kV, Diff. / Comm. 40 Ω	B	2 kV Comm. 40 Ω	FS	1 kV / 2 kV Diff. / Comm. 40 Ω	A 1.0%
	Conducted RF	IEC 61000-4-6	3 V	A	10 V, 10 kHz...150 kHz	A	10 V, 150 kHz...80 MHz	FS	10 V 150 kHz...100 MHz	A 0.5%
I/O signal	Conducted LF	IEC 61000-4-16	Not required		Not required		1.5...15 kHz, 1...10 V 15...150 kHz, 10 V 50/60 Hz, 100 V	FS	15 Hz...150 kHz, 10 V 50 Hz, 300 Ω, 230 V	A 0.5%

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Specified function	Normal test level	Increased test level
Normal function	Normal specification (performance criteria A; B; C)	May fail
Safety function	Performance criteria - A, or - B + observed deviation + recovery time to be documented in the data sheet, or - C + observed behaviour documented in the data sheet	Performance criteria FS (i.e. no effect outside the specification, or defined state)

- A: During testing, normal performance within the specification limits.
- B: During testing, temporary degradation, or loss of function or performance which is self recovering.
- C: During testing, temporary degradation, or loss of function or performance which requires operator intervention or system reset occurs.

9000 EMC specifications - emission:

Class B equipment		Standard CISPR 22	
Disturbance	Test method	Frequency range	Limits
Radiated	Quasi-peak	30 to 230 MHz	30 dB ($\mu\text{V}/\text{m}$)
		230 to 1000 MHz	37 dB ($\mu\text{V}/\text{m}$)
Conducted	Quasi-peak	0.15...0.50 MHz	40 to 30 dB (μA)
	Average		30 to 20 dB (μA)
	Quasi-peak	0.50 to 30 MHz	30 dB (μA)
	Average		20 dB (μA)